# imall

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SEMICONDUCTOR®

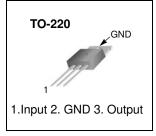
## LM78TXX 3-Terminal 3A Positive Voltage Regulator

### Features

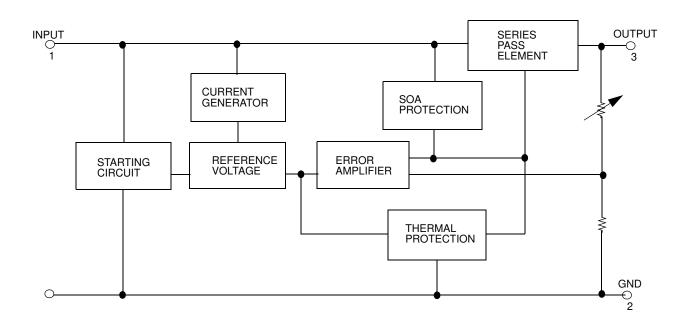
- Output Current in Excess of 3.0A
- Output Transistor Safe Operating Area Compensation
- Power Dissipation :25W
- Internal Short Circuit Current Limiting
- Internal Thermal Overload Protection
- Output Voltage Offered in 4% Tolerance
- No External Components Required
- Output Voltage of 5,12 and 15V

## Description

This family of fixed voltage regulators are monolithic integrated circuit capable of driving loads in excess of 3.0 A.



### Internal Block Diagram



## **Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit	
Input Voltage (for $V_O = 5V$ to $12V$ ) (for $V_O = 15V$ )	VI	35 40	V V	
Power Dissipation	PD	Internally limited		
Thermal Resistance, Junction to Air (Note1, 2) Ta = +25°C	RθJA	65	°C/W	
Thermal Resistance, Junction to Case (Note1) Tc = +25°C	RθJC	2.5	°C/W	
Operating Junction Temperature Range	TJ	0 ~ +125	°C	
Storage Temperature Range	TSTG	-65 ~ +150	°C	

Note:

1. Thermal resistance test board Size: 76.2mm \* 114.3mm \* 1.6mm(1S0P) JEDEC standard: JESD51-3, JESD51-7

2. Assume no ambient airflow.

## **Electrical Characteristics(LM78T05)**

(VI = 10V, IO = 3.0 A,  $0^{\circ}C \le T_J \le +125^{\circ}C$ , Po  $\le P_{MAX}$  (Note3), unless otherwise specified. )

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Output Voltage	Vo	$5mA \le lo \le 3.0A$ , $T_J$ = +25°C 7.3V $\le$ VI $\le$ 20V, $5mA \le lo \le 2.0A$	4.8 4.75	5.0 5.0	5.2 5.25	V
Line Regulation (Note4)	ΔVO	$\begin{array}{l} 7.2V \leq VI \leq 35V \;,\; lo=5mA,\; T_J=+25^\circ C \\ 7.2V \leq VI \leq 35V \;,\; lo=1.0A,\; T_J=+25^\circ C \\ 7.5V \leq VI \leq 20V,\; lo=2.0A,\; T_J=+25^\circ C \\ 8.0V \leq VI \leq 12V,\; lo=3.0A,\; T_J=+25^\circ C \end{array}$		3.0	25	mV
Load Regulation (Note4)	ΔVO	$5mA \le lo \le 3.0A$ , $T_J$ = +25°C $5mA \le lo \le 3.0A$	-	10 15	30 80	mV mV
Thermal Regulation	REGT	Pulse =10ms, P = 20W TA = +25°C	-	0.002	0.03	%Vo/W
Quiescent Current	IQ	$5mA \le lo \le 3.0A$ , $T_J$ = +25°C $5mA \le lo \le 3.0A$	-	3.5 4.0	5.0 6.0	mA mA
Quiescent Current Change	ΔlQ	$\begin{array}{l} 7.2V \leq VI \leq 35V, \ \text{Io} = 5mA \\ T_J = +25^\circ\text{C} \ ; \\ 7.5V \leq VI \leq 20V, \ \text{Io} = 2.0A \ ; \\ 5mA \leq \text{Io} \leq 3.0A, \ T_J = +25^\circ\text{C} \end{array}$	-	0.1	0.8	mA
Ripple Rejection	RR	$f$ = 120Hz, $8V \leq V_I \leq 18V, \ I_0$ = 2.0A $T_J$ = +25°C	-	75	-	dB
Dropout Voltage	VD	lo = 3A ,TJ = +25°C	-	2.2	2.5	V
Output Noise Voltage	VN	$T_A = +25^{\circ}C$ , $10Hz \le f \le 100kHz$	-	10	-	μV/Vo
Peak Output Current	Iрк	TA = +25°C	-	5.0	-	A
Output Resistance	Ro	f = 1.0kHz	-	2.0	-	mΩ
Short Circuit Current Limit	lsc	VI = 35V, TJ =+25°C	-	1.5	2.5	A
Average Temperature Coefficient of Output Voltage	$\Delta V_O / \Delta T$	lo = 5.0mA	-	0.2	-	mV/°C

#### Note:

3. Although power dissipation is internally limited, specifications apply only for PO ≤ Pmax, Pmax = 25W

4. Load and line regulation are specified at constant junction temperature. Change in Vo due heating effects must be taken into account separately. Pulse testing with low duty is used.

## Electrical Characteristics(LM78T12) (Continued)

(VI = 19V, IO = 3.0 A,  $0^{\circ}C \le T_J \le +125^{\circ}C$ , Po  $\le P_{MAX}$  (Note1), unless otherwise specified. )

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Output Voltage	Vo	$5mA \le lo \le 3.0A$ , $T_J$ =+25°C 14.5V $\le$ VI $\le$ 27V, $5mA \le lo \le 2.0A$		12 12	12.5 12.8	V
Line Regulation (Note2)	ΔVO	$\begin{array}{l} 14.5 V \leq VI \leq 35 V, \ lo=5 mA, \ TJ=+25^{\circ}C \\ 14.5 V \leq VI \leq 35 V, \ lo=1.0A, \ TJ=+25^{\circ}C \\ 14.9 V \leq VI \leq 28 V, \ lo=2.0A, \ TJ=+25^{\circ}C \\ 16 V \leq VI \leq 22 V, \ lo=3.0A, \ TJ=+25^{\circ}C \end{array}$		6.0	45	mV
Load Regulation (Note2)	ΔVo	$\begin{array}{l} 5mA \leq lo \leq 3.0A, \ TJ = +25^{\circ}C \\ 5mA \leq lo \leq 3.0A \end{array}$	-	10 15	30 80	mV mV
Thermal Regulation	REGT	Pulse =10ms, P = 20W TA = $+25^{\circ}C$		0.002	0.03	%Vo/W
Quiescent Current	lQ	$\begin{array}{l} 5mA \leq lo \leq 3.0A, \ T_J = +25^{\circ}C \\ 5mA \leq lo \leq 3.0A \end{array}$	-	3.5 4.0	5.0 6.0	mA mA
Quiescent Current Change	ΔlQ	$\begin{array}{l} 14.5V \leq VI \leq 35V, \ \text{Io} = 5mA \\ T_J = +25^\circ C \ ; \\ 14.9V \leq VI \leq 27V, \ \text{Io} = 2.0A \ ; \\ 5mA \leq \text{Io} \leq 3.0A, \ T_J = +25^\circ C \end{array}$	-	0.1	0.8	mA
Ripple Rejection	RR	f = 120Hz, 15V $\leq$ VI $\leq$ 25V, Io = 2.0A TJ =+25°C	-	67	-	dB
Dropout Voltage	VD	lo = 3A,TJ =+25°C	-	2.2	2.5	V
Output Noise Voltage	VN	$T_{A} = +25^{\circ}C, \ 10Hz \leq f \leq 100 kHz$	-	10	-	μV/Vo
Peak Output Current	lрк	T <sub>A</sub> =+25°C	-	5.0	-	А
Output Resistance	Ro	f = 1.0kHz		2.0	-	mΩ
Short Circuit Current Limit	lsc	VI = 35V, TJ =+25°C	-	1.5	2.5	A
Average Temperature Coefficient of Output Voltage	$\Delta V_O / \Delta T$	lo = 5.0mA	-	0.5	-	mV/°C

#### Note:

1. Although power dissipation is internally limited, specifications apply only for  $P_O \le Pmax$ , Pmax = 25W

 Load and line regulation are specified at constant junction temperature. Change in Vo due heating effects must be taken into account separately. Pulse testing with low duty is used. (PMAX = 25W)

## Electrical Characteristics(LM78T15) (Continued)

(VI = 23V, IO = 3.0 A,  $0^{\circ}C \le T_J \le +125^{\circ}C$ , Po  $\le P_{MAX}$  (Note1), unless otherwise specified. )

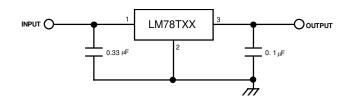
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Output Voltage	Vo	$\begin{array}{l} 5mA \leq lo \leq 3.0A, \ T_J = +25^{\circ}C \\ 17.5V \leq VI \leq 30V, \ 5mA \leq lo \leq 2.0A \end{array}$		15 15	15.6 15.75	V
Line Regulation (Note2)	ΔVO	$\begin{array}{l} 17.6V \leq VI \leq 40V, \ \text{lo}{=}5\text{mA}, \ \text{TJ} = +25^{\circ}\text{C} \\ 17.6V \leq VI \leq 40V, \ \text{lo}{=}1.0\text{A}, \ \text{TJ} = +25^{\circ}\text{C} \\ 18V \leq VI \leq 30V, \ \text{lo} = 2.0\text{A}, \ \text{TJ} = +25^{\circ}\text{C} \\ 20V \leq VI \leq 26V, \ \text{lo} = 3.0\text{A}, \ \text{TJ} = +25^{\circ}\text{C} \\ \end{array}$		7.5	55	mV
Load Regulation (Note2)	ΔVO	$\begin{array}{l} 5mA \leq lo \leq 3.0A, \ T_J = +25^\circ C \\ 5mA \leq lo \leq 3.0A \end{array}$	-	10 15	30 80	mV mV
Thermal Regulation	REGT	Pulse =10ms, P = 20W T <sub>A</sub> = +25°C		0.002	0.03	%Vo/W
Quiescent Current	lQ	$\begin{array}{l} 5mA \leq lo \leq 3.0A, \ T_J = +25^\circ C \\ 5mA \leq lo \leq 3.0A \end{array}$	-	3.5 4.0	5.0 6.0	mA mA
Quiescent Current Change	ΔlQ	$\begin{array}{l} 17.6V \leq VI \leq 40V, \ \text{lo} = 5mA \\ T_J = +25^\circ C \ ; \\ 18V \leq VI \leq 30V, \ \text{lo} = 2.0A \ ; \\ 5mA \leq \text{lo} \leq 3.0A, \ T_J = +25^\circ C \end{array}$		0.1	0.8	mA
Ripple Rejection	RR	f = 120Hz, 18.5V $\leq$ VI $\leq$ 28.5V, Io = 2.0A TJ =+25°C		65	-	dB
Dropout Voltage	VD	lo = 3A ,TJ = +25°C	-	2.2	2.5	V
Output Noise Voltage	VN	$T_{A} = +25^{\circ}C, \ 10Hz \leq f \leq 100 kHz$	-	10	-	μV/Vo
Peak Output Current	IPK	$T_A = +25^{\circ}C$		5.0	-	A
Output Resistance	Ro	f = 1.0kHz		2.0	-	mΩ
Short Circuit Current Limit	lsc	VI = 40V, TJ = +25°C	-	1.0	2.0	A
Average Temperature Coefficient of Output Voltage	$\Delta V_O / \Delta T$	lo = 5.0mA	-	0.5	-	mV/°C

#### Note:

1. Although power dissipation is internally limited, specifications apply only for  $P_O \le Pmax$ , Pmax = 25W

2. Load and line regulation are specified at constant junction temperature. Change in Vo due heating effects must be taken into account separately. Pulse testing with low duty is used. ( PMAX = 25W)

## **Typical Application**



#### Note:

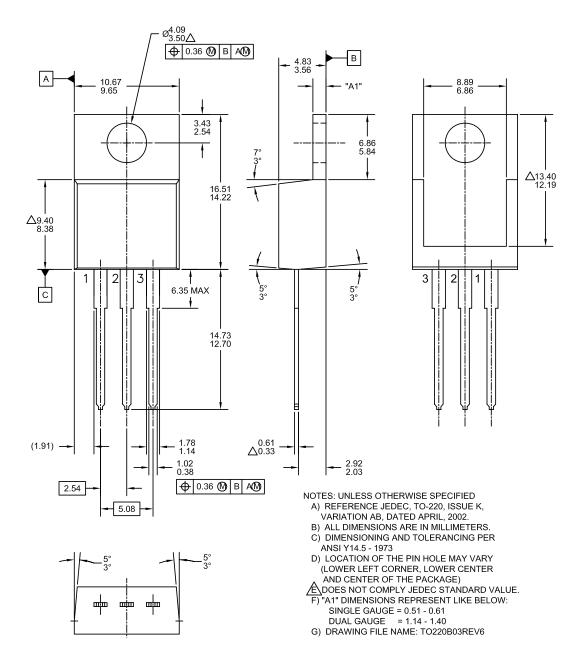
- 1. To specify an output voltage, substitute voltage value for "XX".
- Bypass Capacitors are recommend for optimum stability and transient response and should be located as close as possible to the regulator 2.

### **Mechanical Dimensions**

#### Package

#### **Dimensions in millimeters**

## TO-220 [ SINGLE GAUGE ]



## **Ordering Information**

Product Number	Package	Operating Temperature
LM78T05CT		
LM78T12CT	TO-220	0 ~ +125°C
LM78T15CT		

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